## Abstract Submitted for the GEC05 Meeting of The American Physical Society

Time-Resolved Optical Emission Studies of Pulsed DC Magnetron Plasmas<sup>1</sup> JOSE LOPEZ, WEIDONG ZHU, ABRAHAM BELKIND, Stevens Institute of Technology, KURT H. BECKER, Stevens Institute of Technology and Center for Environmental Systems, STEVENS INSTITUTE OF TECH-NOLOGY, HOBOKEN, NJ, USA TEAM, CENTER FOR ENVIRONMENTAL SYSTEMS, HOBOKEN, NJ, USA TEAM — Pulsed DC unbalanced magnetron sputtering is a well-developed deposition technique for coatings and thin films and is widely used in industry to deposit thin films such as alumina, Al<sub>2</sub>O<sub>3</sub> and titania, TiO<sub>2</sub>. The pulsed modulation of the direct current (DC) has been demonstrated to create plasmas that solve many of the arcing problems observed in DC magnetrons which can lead to non-uniform removal of material from the anode resulting in poor or unusable thin films for high-tech applications. The intense photon emission from the pulsed DC magnetron sputtering plasmas allows for the investigation of the optical plasma emissions with a fast intensified CCD (ICCD) camera. The non-intrusive diagnostic methods of time-resolved optical emission spectroscopy (TR-OES) and time- resolved imaging were used to study the temporal behavior of the various plasma species.

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